

LINEAR INTEGRATED CIRCUITS

7929225 S G S SEMICONDUCTOR CORP

TV VERTICAL DEFLECTION SYSTEM

The TDA 1170S is a monolithic integrated circuit in a 12-lead quad in-line plastic package. It is intended for use in black and white and colour TV receivers. The functions incorporated are:

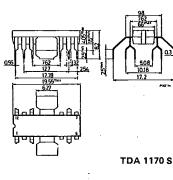
- synchronization circuit
- oscillator and ramp generator
- high power gain amplifier
- flyback generator
- voltage regulator

ABSOLUTE MAXIMUM RATINGS

V _s	Supply voltage at pin 2	35	v
V_4, V_5	Flyback peak voltage	60	v
V_{10}	Power amplifier input voltage	· + 10	v
- 10		- 0.5	v
۱.	Output peak current (non repetitive) at $t = 2$ msec	2	Α
l.	Output peak current at f = 50 Hz t ≤ 10 µsec	2.5	А
	Output peak current at f = 50 Hz t > 10 μ sec	1.5	Α
 [3	Pin 3 DC current at $V_4 < V_2$	100	mΑ
l ₃	Pin 3 peak to peak flyback current for $f = 50 \text{ Hz}$, $t_{fly} \le 1.5 \text{ msec}$	1.8	А
- ₈	Pin 8 current	± 20	mΑ
P _{tot}	Power dissipation: at $T_{tab} = 90^{\circ}C$	5	W
. נסנ	Power dissipation: at $T_{tab} = 90^{\circ}C$ at $T_{amb} = 80^{\circ}C$ TDA1170S	1	w
T _{stg} , T _j	Storage and junction temperature	-40 to 150	°C

ORDERING NUMBERS: TDA 1170 S TDA 1170 SH

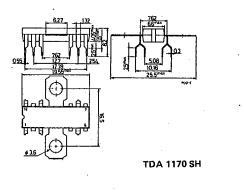
MECHANICAL DATA



F-10

1065

353

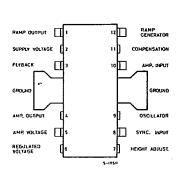


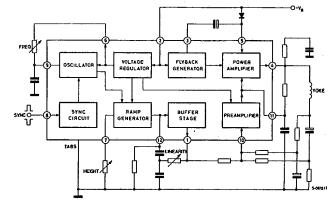
6/82

Dimensions in mm

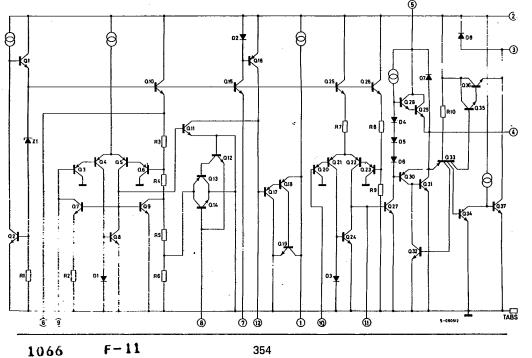
TDA1170S

CONNECTION AND BLOCK DIAGRAMS





SCHEMATIC DIAGRAM



S G S-THOMSON D7E D 7929237 D012458 4

T-77-07-11



7929225 S G S SEMICONDUCTOR CORP

THERMAL DATA		TDA 1170S	TDA 1170SH
R _{th j-tab}	Thermal resistance junction-tab	max 12°C/W	max 10°C/W
R _{th j-amb}	Thermal resistance junction-ambient	max 70°C/W(°)	max 80°C/W

(-) Obtained with tabs soldered to printed circuit with minimized copper area.

ELECTRICAL CHARACTERISTICS (Refer to the test circuits, $V_s = 35V$, $T_{amb} = 25^{\circ}C$, unless otherwise specified) 1 1 T ...

	Parameter	Test conditions	Min.	Тур.	Max.	Unit	Fig.
C CHAR	ACTERISTICS	1					
l ₂	Pin 2 quiescent current	l ₃ = 0		7	14	mA	1b
l ₅	Pin 5 quiescent current	I ₄ = 0		8	15	mA	1b
-19	Oscillator bias current	V _g = 1V		0.1	1	μA	1a
-!10	Amplifier input bias current	V ₁₀ = 1V		0.1	1	μA	1b
-l ₁₂	Ramp generator bias current	V ₁₂ =0		0.02	0.3	μA	1a
-l ₁₂	Ramp generator current	$I_7 = 20 \mu A V_{12} = 0$	19	20	24	μA	1b
ΔI ₁₂ I ₁₂	Ramp generator non-linearity	$\Delta V_{12} = 0$ to 12V I ₇ = 20 μA		0.2	1	%	1b
Vs	Supply voltage range		10		36	V 1	-
V ₁	Pin 1 saturation voltage to ground	i ₁ = 1 mA		1	1.4	V	
V ₃	Pin 3 saturation voltage to ground	I ₃ = 10 mA		1.7	2.6	V	1a
V ₄	Quiescent output voltage	V _s = 10V R ₁ =10 KΩ R ₂ =10 KΩ	4,17	4.4	4.63	V	1 a
		V _s = 35V R ₁ =30 KΩ R ₂ = 10 KΩ	8.35	8.8	9.25	V	1a
V _{4L}	Output saturation voltage to	-I ₄ = 0.1A		0.9	1.2	v	1c
	ground	-1 ₄ = 0.8A		1.9	2.3	V	1c
V _{4H}	Output saturation voltage to	I ₄ = 0.1A		1.4	2.1	V	1d
	supply	I ₄ = 0.8A		2.8	3.2	V	1d
V ₆ .	Regulated voltage at pin 6		6.1	6.5	6.9	V	1b
V ₇	Regulated voltage at pin 7	l ₇ = 20 μA	6.2	6.6	7	V	1b
$\frac{\Delta V_6}{\Delta V_s}; \frac{\Delta V_7}{\Delta V_s}$	Regulated voltage drift with supply voltage	∆V _s = 10 to 35V		1		mV/V	. 1b
V ₁₀	Amplifier input reference voltage		2.07	2.2	2,3	v	-
R ₈	Pín 8 input resistance	V ₈ ≤ 0.4V	1			MΩ	- 1a

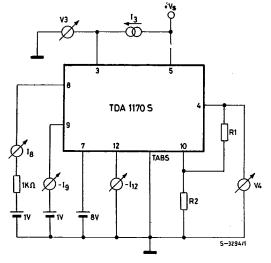
1067

355

F-12

S G S-THOMSON D7E D 7929237 DD12459 6 T-77-07-11

Fig. 1 - DC test circuits



TDA1170S

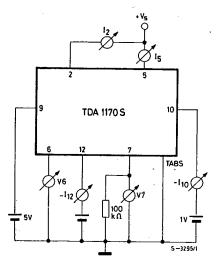
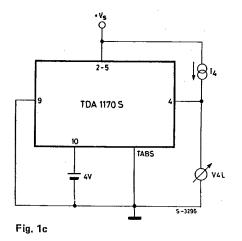
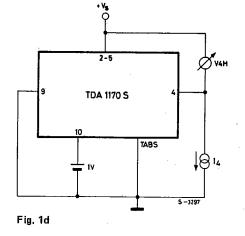




Fig. 1b

356





1068 F-13

Downloaded from Elcodis.com electronic components distributor

T-77-07-11

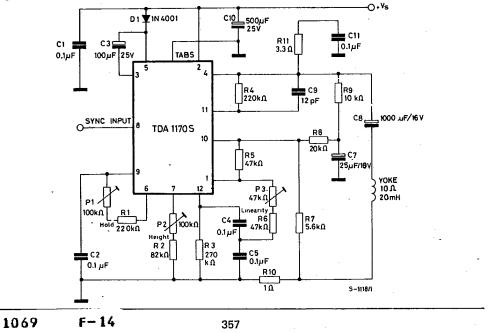


7929225 S G S SEMICONDUCTOR CORP

AC CHARACTERISTICS (Refer to the test circuit, $V_s = 25V$; f = 50 Hz; $T_{amb} = 25^{\circ}C$, unless otherwise specified)

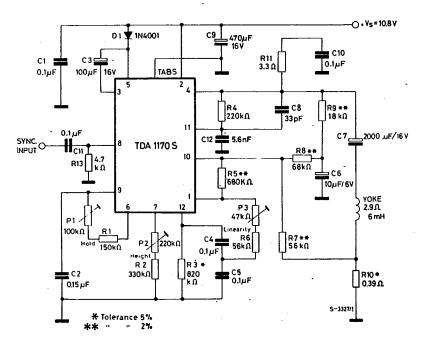
	Parameter	Test conditions	Min.	Typ.	Max.	Unit	Fig.
ls	Supply current	l _y = 1 App		140		mA	2
18	Sync. input current (positive or negative)		500			μA	2
V4.	Flyback voltage	I _y ≓ 1 App		51		V	2
V9	Peak to peak oscillator sawtooth voltage			2.4		V	2
t _{fly}	Flyback time	l _y = 1 App		0.7		ms	2
fo	Free running frequency	$(P_1 + R_1) = 300 \text{ K}\Omega$ $C_2 = 100 \text{ nF}$		44		Hz	2
		$(P_1 + R_1) = 260 \text{ K}\Omega$ $C_2 = 100 \text{ nF}$		52		Hz	2
∆f	Synchronization range	l ₈ = 0.5 mA	14.			Hz	2
Δf ΔVs	Frequency drift with supply voltage	V _s = 10 to 35V		0.005		Hz/V	2
<u>∆f</u> ∆T _{tab}	Frequency drift with tab temperature	T _{tab} = 40 to 120°C		0.01		Hz/∘C	2

Fig. 2 - AC test circuit



S G S-THOMSON D7E D 7929237 DD12461 4 T-77-07-11 7929225 S G S SEMICONDUCTOR CORP TDA1170S

Fig. 3 - Typical application circuit for small screen B/W TV set ($R_y = 2.9\Omega$, $L_y = 6$ mH; $I_y = 1.1$ App)



Typical performance

V.	Operating supply voltage	10.8	v
I,	Supply current	155	mA
t _{fly}	Flyback time	0.5	ms
P _{tot}	TDA 1170S power dissipation	1.35	W
ly	Maximum scanning current (peak to peak)	1.30	Α

For safe working up to T_{amb} = 60°C a heatsink of R_{th} = 30°C/W is required.

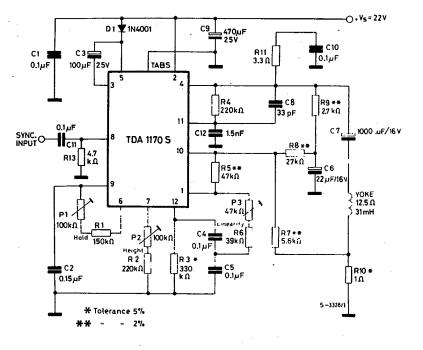
1070

358

G-01

7929225 S G S SEMICONDUCTOR CORP

Fig. 4 – Typical application circuit for small screen 90° PIL TVC set (R_y = 12.5 Ω ; L_y = 31 mH; l_y = 0.8 App)



Typical performance

V _s	Operating supply voltage	22	V.
l,	Supply current	120	mA
t _{fly}	Flyback time	0.8	ms
P _{tot}	TDA 1170S power dissipation	1.95	w
l _y	Maximum scanning current (peak to peak)	1.0	А

For safe working up to $T_{amb} = 60^{\circ}$ C a heatsink of $R_{th} = 18^{\circ}$ C/W is required.

1071

359

9

6 - 02

 S G S-THOMSON D7E D
 7729237 D012463 A
 T-77-07-11

 7929225 S G S SEMICONDUCTOR CORP

TDA1170S

0 . Vs = 22 V D 1 🛨 1N4001 70µГ C10 R11 3.3 D Cl C35 0.1µF TABS 0.1µF 100µF 25V 24 R9 ** 27 κΩ R.4 220kΩ 11 0.1µP c7⊆ F/16 vµF/16 v SYNC. O--C12 1.5nF 11_{C11} TDA 1170 S R8 ** 10 4.7k0 R13 27kΩ ______ 47kΩ C6 22 µF/16 YOKE 10 Ω 20mH P3 47kΩ 191 100kΩ [_______ Hold 150kΩ P.2 Height J R 2 180 kΩ R6 39kΩ R7** 5.6kΩ C4 . 1µF |R3 = |330 [kΩ c2 0.15 μF С5 0.1µF S-3329/1 * Tolerance 5%

Fig. 5 - Typical application circuit for large screen B/W TV set (Ry= 10Ω ; Ly= 20 mH; ly= 1 App)

Typical performance

G-03

V,	Operating supply voltage	22	V	-
l,	Supply current	145	mA	
t _{fly}	Flyback time	0.7	ms	
Ptot	TDA 1170S power dissipation	2.3	W	1
l _v	Maximum scanning current (peak to peak)	1.2	Α	
,	•			

For safe working up to $T_{amb} = 60^{\circ}$ C a heatsink of $R_{th} = 14^{\circ}$ C/W is required.

1	0	7	2	

•

.

S G S-THOMSON D7E D 7929237 0012464 0 T-77-07-11

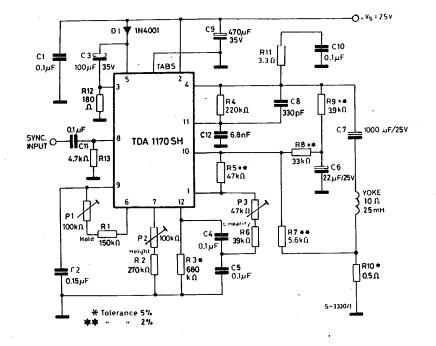


Fig. 6 - Typical application circuit for large screen 110° PIL TVC set ($R_y = 10\Omega$; $L_y = 25$ mH; $I_y = 1.25$ App)

Typical performance

6-04

V _s	Operating supply voltage	25	V
	Supply current	175	mA
t _{fly}	Flyback time	1	ms
P _{tot}	TDA 1170SH power dissipation	3.25	W
l _y	Maximum scanning current (peak to peak)	1.4	A

For safe working up to T_{amb} = 60°C a heatsink of R_{th} = 8.5°C/W is required.

1073

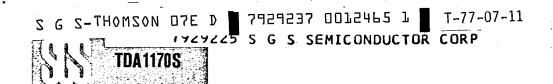
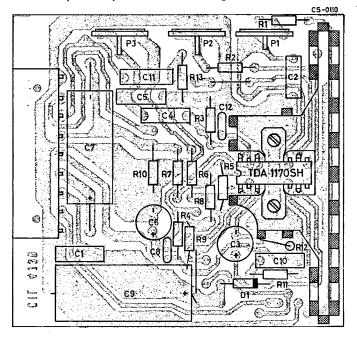


Fig. 7 - P.C. board and component layout of the circuit of fig. 6 (1:1 scale)



Note: For the heatsink (1170 S and 1170 SH) see mounting instructions

MOUNTING INSTRUCTIONS

6-05

During soldering the tab temperature must not exceed 260°C and the soldering time must not be longer than 12 seconds.

The external heatsink or printed circuit copper area must be connected to electrical ground.

TDA 1170S

The junction to ambient thermal resistance of the TDA 1170S can be reduced by soldering the tabs to a suitable copper area of the printed circuit board (fig. 8) or to an external heatsink (fig. 9). The diagram of fig. 10 shows the maximum dissipable power P_{tot} and the $R_{th \ J-amb}$ as a function of the side "s" of two equal square copper areas having a thickness of 35 μ (1.4 mil).

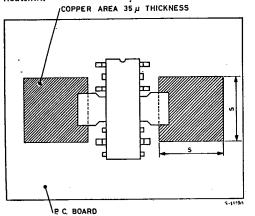
1074



7929225 S G S SEMICONDUCTOR CORP

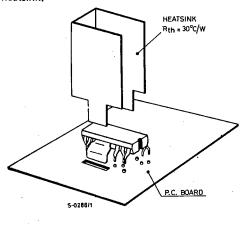
MOUNTING INSTRUCTIONS (continued)

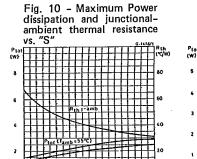
Fig. 8 - Example of P.C. board copper area used as heatsink.



40 s (mm)

Fig. 9 - Example of TDA 1170 S with external heatsink.



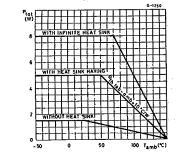


30

G = 06

Fig. 11 - Maxim. allowable power dissipation vs. am-bient temp. (TDA1170S)

Fig. 12 - Maxim. allowable power dissipation vs. am-bient temp. (TDA1170SH)



TDA 1170SH

The power dissipated in the circuit may be removed by connecting the tabs to an external heatsink according to fig. 12. The desired thermal resistance may be obtained by fixing the TDA1170SH to a suitable dimensioned plate as shown in fig. 13.

50 T_{amb}(*¢)

1075

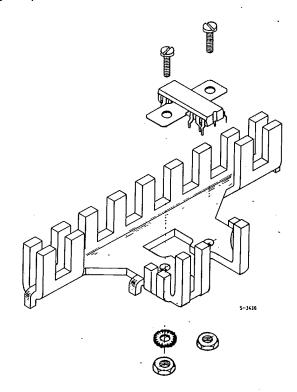
5

S G S-THOMSON D7E D 7929237 0012467 5 T-77-07-11 7929225 S G S SEMICONDUCTUK CORP

MOUNTING INSTRUCTIONS (continued)

Fig. 13 - Mounting example.

2 12 13 13



364

G-07